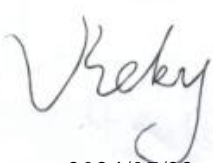


TEST REPORT

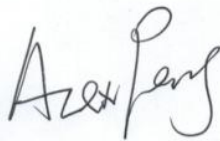
Customer information	Client	Mid Ocean Brands B.V.
	Address	7/F., Kings Tower, 111 King Lam Street, Cheung Sha Wan, Kowloon, Hong Kong
Sample information	Name of sample	Bamboo wireless charger
	Test Model No.	MO9914
	Trade mark	N/A
	Lot number	----
	Manufacturer	114628
Test information	Sample received	July 12, 2024
	Testing date	July 12, 2024 to July 22, 2024
	Test sort	Commission Test
	Requested/item	RoHS directive 2011/65/EU Annex II amending Annex(EU)2015/863. (1) Lead, Cadmium, Mercury, Hexavalent Chromium, PBBs and PBDEs Content. (2) Di-(2-ethylhexyl) phthalate(DEHP), Benzylbutyl phthalate(BBP), Dibutyl phthalate(DBP), Disobutyl phthalate(DIBP) Content.
	Standard/ Foundation	(1)With reference to IEC 62321-3-1:2013, scanning by XRF Spectroscopy Chemical test method: With reference to IEC 62321-5:2013, determination of Cadmium, lead by ICP With reference to IEC 62321-4:2013+AMD1:2017, determination of Mercury by ICP With reference to IEC 62321-7-2:2017&IEC 62321-7-1:2015, determination of Hexavalent Chromium by Colorimetric method. With reference to IEC 62321-6:2015 determination of PBBs and PBDEs by GC-MS (2)With reference to IEC 62321-8:2017, and analysis was performed by GC-MS.
	Conclusion	(1)The tested sample complied with RoHS directive (2011/65/EU). (2)The tested part of submitted sample complied with directive (EU)2015/863
Remark	----	

Tested By:



Date: 2024/07/22

Checked By:



Date: 2024/07/22

Approved By:



Date: 2024/07/22

SHENZHEN SIT TESTING TECHNOLOGY CO LTD.

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Test result: 1. Structural parts

No.	COMPONENTS	Item	Results of EDXRF (P/F/D)	Results of Testing (mg/kg)	Chemical testing limit (mg/kg)	Conclusion (P/F)
1	Bamboo shell	Cd	P	N.D.	<100	P
		Cr(VI)	P	N.D.	<1000	P
		Hg	P	N.D.	<1000	P
		Pb	P	N.D.	<1000	P
		PBBs	P	N.D.	<1000	P
		PBDEs	P	N.D.	<1000	P
2	Transparent solid glue	Cd	P	N.D.	<100	P
		Cr(VI)	P	N.D.	<1000	P
		Hg	P	N.D.	<1000	P
		Pb	P	N.D.	<1000	P
		PBBs	P	N.D.	<1000	P
		PBDEs	P	N.D.	<1000	P
3	Solder	Cd	P	N.D.	<100	P
		Cr(VI)	P	N.D.	<1000	P
		Hg	P	N.D.	<1000	P
		Pb	P	N.D.	<1000	P
		PBBs	/	/	<1000	/
		PBDEs	/	/	<1000	/
4	IC	Cd	P	N.D.	<100	P
		Cr(VI)	P	N.D.	<1000	P
		Hg	P	N.D.	<1000	P
		Pb	P	N.D.	<1000	P
		PBBs	P	N.D.	<1000	P
		PBDEs	P	N.D.	<1000	P
5	IC feet	Cd	P	N.D.	<100	P
		Cr(VI)	P	N.D.	<1000	P
		Hg	P	N.D.	<1000	P
		Pb	P	N.D.	<1000	P
		PBBs	/	/	<1000	/
		PBDEs	/	/	<1000	/
6	Brown inductance	Cd	P	N.D.	<100	P
		Cr(VI)	P	N.D.	<1000	P
		Hg	P	N.D.	<1000	P
		Pb	P	N.D.	<1000	P
		PBBs	P	N.D.	<1000	P
		PBDEs	P	N.D.	<1000	P

No.	COMPONENTS	Item	Results of EDXRF (P/F/D)	Results of Testing (mg/kg)	Chemical testing limit (mg/kg)	Conclusion (P/F)
7	Solder	Cd	P	N.D.	<100	P
		Cr(VI)	P	N.D.	<1000	P
		Hg	P	N.D.	<1000	P
		Pb	P	N.D.	<1000	P
		PBBs	/	/	<1000	/
		PBDEs	/	/	<1000	/
8	Grey inductance	Cd	P	N.D.	<100	P
		Cr(VI)	P	N.D.	<1000	P
		Hg	P	N.D.	<1000	P
		Pb	P	N.D.	<1000	P
		PBBs	P	N.D.	<1000	P
		PBDEs	P	N.D.	<1000	P
9	Black inductance	Cd	P	N.D.	<100	P
		Cr(VI)	P	N.D.	<1000	P
		Hg	P	N.D.	<1000	P
		Pb	P	N.D.	<1000	P
		PBBs	P	N.D.	<1000	P
		PBDEs	P	N.D.	<1000	P
10	Solder	Cd	P	N.D.	<100	P
		Cr(VI)	P	N.D.	<1000	P
		Hg	P	N.D.	<1000	P
		Pb	P	N.D.	<1000	P
		PBBs	/	/	<1000	/
		PBDEs	/	/	<1000	/
11	USB metal port	Cd	P	N.D.	<100	P
		Cr(VI)	P	N.D.	<1000	P
		Hg	P	N.D.	<1000	P
		Pb	P	N.D.	<1000	P
		PBBs	/	/	<1000	/
		PBDEs	/	/	<1000	/
12	Black plastic port	Cd	P	N.D.	<100	P
		Cr(VI)	P	N.D.	<1000	P
		Hg	P	N.D.	<1000	P
		Pb	P	N.D.	<1000	P
		PBBs	P	N.D.	<1000	P
		PBDEs	P	N.D.	<1000	P

No.	COMPONENTS	Item	Results of EDXRF (P/F/D)	Results of Testing (mg/kg)	Chemical testing limit (mg/kg)	Conclusion (P/F)
13	Silver metal feet	Cd	P	N.D.	<100	P
		Cr(VI)	P	N.D.	<1000	P
		Hg	P	N.D.	<1000	P
		Pb	P	N.D.	<1000	P
		PBBs	/	/	<1000	/
		PBDEs	/	/	<1000	/
14	White chip	Cd	P	N.D.	<100	P
		Cr(VI)	P	N.D.	<1000	P
		Hg	P	N.D.	<1000	P
		Pb	P	N.D.	<1000	P
		PBBs	P	N.D.	<1000	P
		PBDEs	P	N.D.	<1000	P
15	Black component	Cd	P	N.D.	<100	P
		Cr(VI)	P	N.D.	<1000	P
		Hg	P	N.D.	<1000	P
		Pb	P	N.D.	<1000	P
		PBBs	P	N.D.	<1000	P
		PBDEs	P	N.D.	<1000	P
16	Green PCB board	Cd	P	N.D.	<100	P
		Cr(VI)	P	N.D.	<1000	P
		Hg	P	N.D.	<1000	P
		Pb	P	N.D.	<1000	P
		PBBs	P	N.D.	<1000	P
		PBDEs	P	N.D.	<1000	P
17	Black board	Cd	P	N.D.	<100	P
		Cr(VI)	P	N.D.	<1000	P
		Hg	P	N.D.	<1000	P
		Pb	P	N.D.	<1000	P
		PBBs	P	N.D.	<1000	P
		PBDEs	P	N.D.	<1000	P
18	White paper	Cd	P	N.D.	<100	P
		Cr(VI)	P	N.D.	<1000	P
		Hg	P	N.D.	<1000	P
		Pb	P	N.D.	<1000	P
		PBBs	P	N.D.	<1000	P
		PBDEs	P	N.D.	<1000	P

No.	COMPONENTS	Item	Results of EDXRF (P/F/D)	Results of Testing (mg/kg)	Chemical testing limit (mg/kg)	Conclusion (P/F)
19	Wire skin	Cd	P	N.D.	<100	P
		Cr(VI)	P	N.D.	<1000	P
		Hg	P	N.D.	<1000	P
		Pb	P	N.D.	<1000	P
		PBBs	P	N.D.	<1000	P
		PBDEs	P	N.D.	<1000	P
20	Copper wire	Cd	P	N.D.	<100	P
		Cr(VI)	P	N.D.	<1000	P
		Hg	P	N.D.	<1000	P
		Pb	P	N.D.	<1000	P
		PBBs	/	/	<1000	/
		PBDEs	/	/	<1000	/
21	Solder	Cd	P	N.D.	<100	P
		Cr(VI)	P	N.D.	<1000	P
		Hg	P	N.D.	<1000	P
		Pb	P	N.D.	<1000	P
		PBBs	/	/	<1000	/
		PBDEs	/	/	<1000	/
22	Golden plastic tape	Cd	P	N.D.	<100	P
		Cr(VI)	P	N.D.	<1000	P
		Hg	P	N.D.	<1000	P
		Pb	P	N.D.	<1000	P
		PBBs	P	N.D.	<1000	P
		PBDEs	P	N.D.	<1000	P

Remark:

- 1 It is the result on total Br while test PBBs and PBDEs by EDXRF. It is the result on total Cr while test Hexavalent Chromium by EDXRF.
- 2 Results are obtained by EDXRF for primary screening, and chemical testing by ICP (for Cd, Pb, Hg),UV-VIS (Cr(VI)) and GCMS (for PBBs, PBDEs) is recommended to be performed.
- 3.

Element	Polymer	Metal	Composite Materials
Cd	$P \leq 70-3\sigma < D < 130+3\sigma \leq F$	$P \leq 70-3\sigma < D < 130+3\sigma \leq F$	$P \leq 50-3\sigma < D < 150+3\sigma \leq F$
Pb	$P \leq 700-3\sigma < D < 1300+3\sigma \leq F$	$P \leq 700-3\sigma < D < 1300+3\sigma \leq F$	$P \leq 500-3\sigma < D < 1500+3\sigma \leq F$
Hg	$P \leq 700-3\sigma < D < 1300+3\sigma \leq F$	$P \leq 700-3\sigma < D < 1300+3\sigma \leq F$	$P \leq 500-3\sigma < D < 1500+3\sigma \leq F$
Br	$P \leq 300-3\sigma < D$	----	$P \leq 250-3\sigma < D$
Cr	$P \leq 700-3\sigma < D$	$P \leq 700-3\sigma < D$	$P \leq 500-3\sigma < D$

P = PASS; F = FAIL; D = DETECTED;

4. mg/kg = ppm; N.D. = NOT DETECTED (<MDL) Pb, Cd, Hg,Cr(VI): 2mg/kg; PBBs, PBDEs: 5mg/kg
5. With reference to IEC 62321:-7-1:2015, result on Cr (VI) for metal sample is shown as Positive/Negative.
Positive = Presence of Cr(VI) coating, Negative = Absence of Cr(VI) coating
- 6 *According to Annex III of European Council Directive 2011/65/EU, Lead in copper alloy containing up to 4% lead by weight.
- 7 **According to Annex III of European Council Directive 2011/65/EU, Lead in steel alloy containing up to 0.35% lead by weight.
- 8 #According to Annex III of European Council Directive 2011/65/EU, Cadmium and its compounds in electrical contacts is exempted.

(3) DEHP, BBP, DBP, DIBP

ITEM \ SAMPLE No.	SAMPLE CONCENTRATION (mg/kg)					MDL (mg/kg)	REQUIRED LIMIT (mg/kg)
	1	2	4	6	8		
Di-2-ethylhexyl phthalate (DEHP)	ND	ND	ND	ND	ND	30	1000
Dibutyl phthalate (DBP)	ND	ND	ND	ND	ND	30	1000
Benzylbutyl phthalate (BBP)	ND	ND	ND	ND	ND	30	1000
Diisobutyl phthalate (DIBP)	ND	ND	ND	ND	ND	30	1000

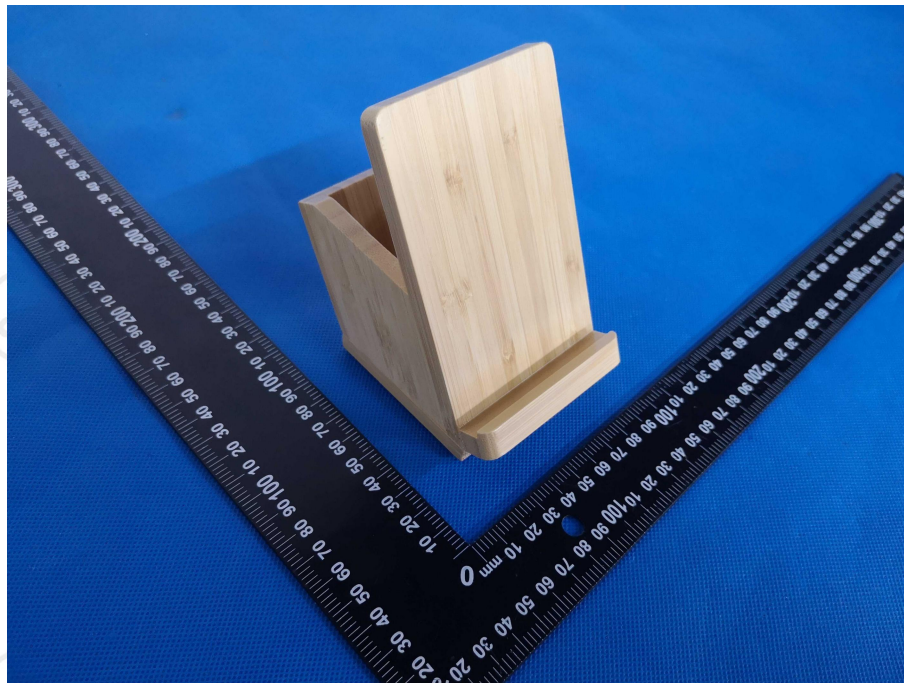
ITEM \ SAMPLE No.	SAMPLE CONCENTRATION (mg/kg)					MDL (mg/kg)	REQUIRED LIMIT (mg/kg)
	9	12	14	15	16		
Di-2-ethylhexyl phthalate (DEHP)	ND	ND	ND	ND	ND	30	1000
Dibutyl phthalate (DBP)	ND	ND	ND	ND	ND	30	1000
Benzylbutyl phthalate (BBP)	ND	ND	ND	ND	ND	30	1000
Diisobutyl phthalate (DIBP)	ND	ND	ND	ND	ND	30	1000

ITEM \ SAMPLE No.	SAMPLE CONCENTRATION (mg/kg)				MDL (mg/kg)	REQUIRED LIMIT (mg/kg)
	17	18	19	22		
Di-2-ethylhexyl phthalate (DEHP)	ND	ND	ND	ND	30	1000
Dibutyl phthalate (DBP)	ND	ND	ND	ND	30	1000
Benzylbutyl phthalate (BBP)	ND	ND	ND	ND	30	1000
Diisobutyl phthalate (DIBP)	ND	ND	ND	ND	30	1000

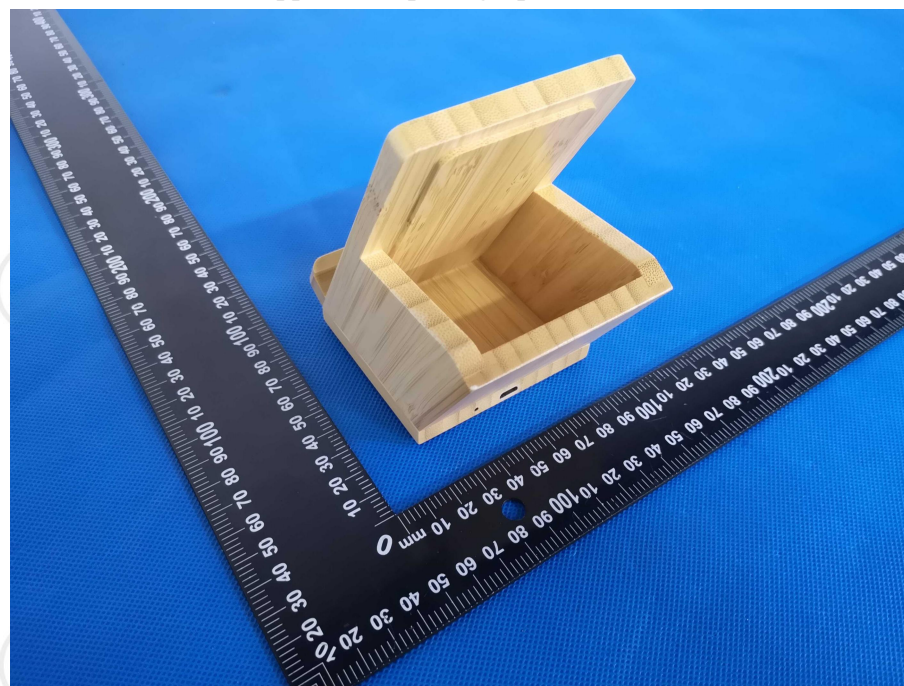
Note: MDL = Method Detection Limit, ND=not detected (<Method Detection Limit).

Sample photo

Appearance photograph of EUT

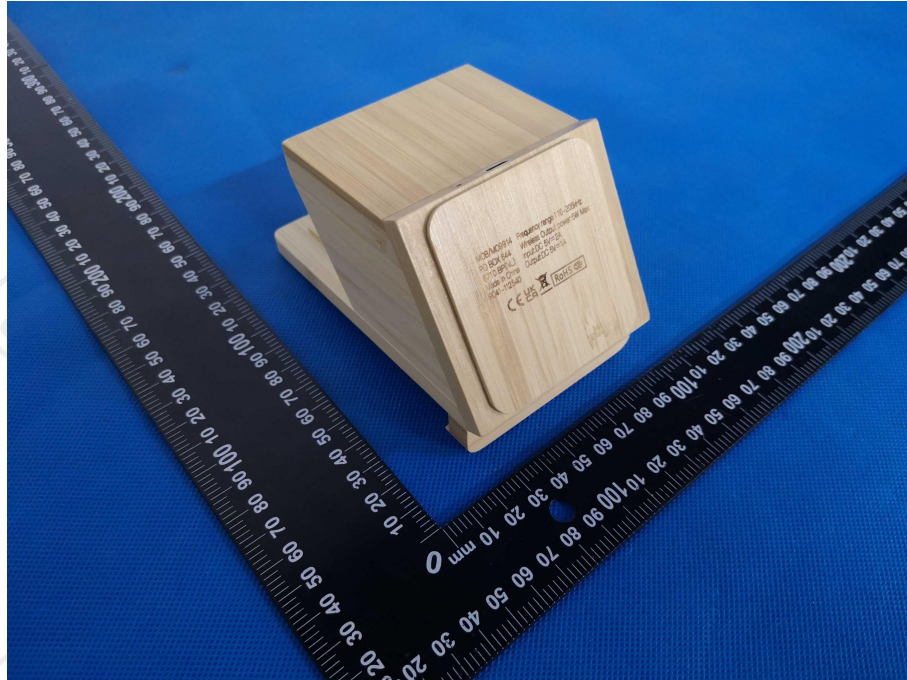


Appearance photograph of EUT

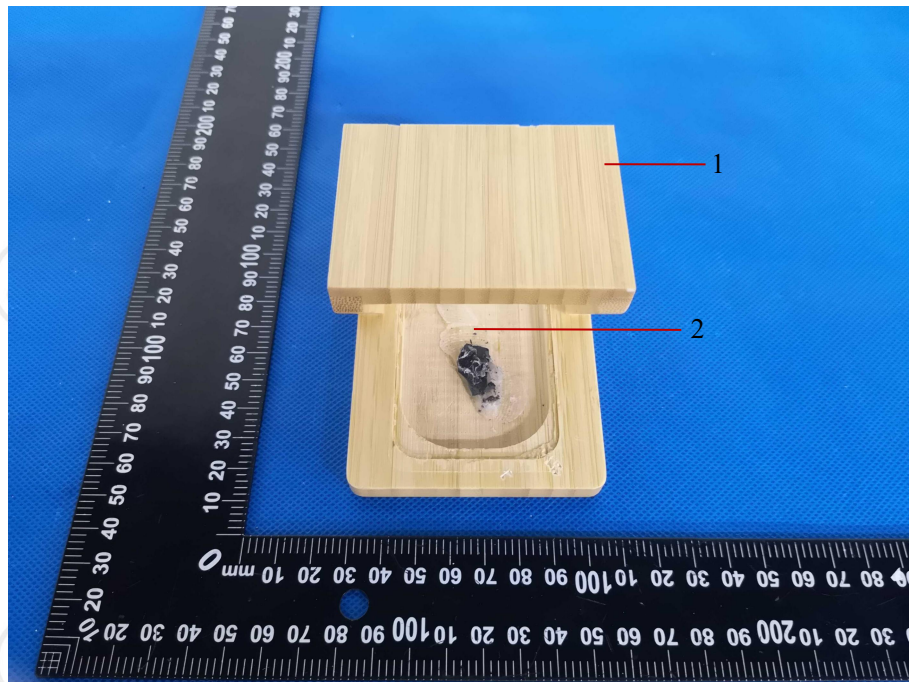


Sample photo

Appearance photograph of EUT



Appearance photograph of EUT

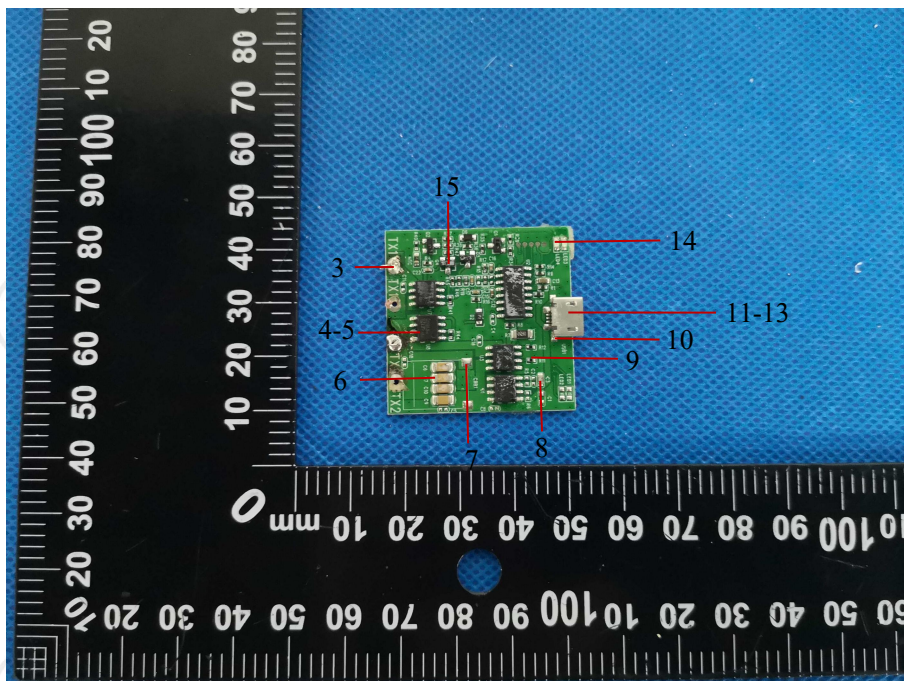


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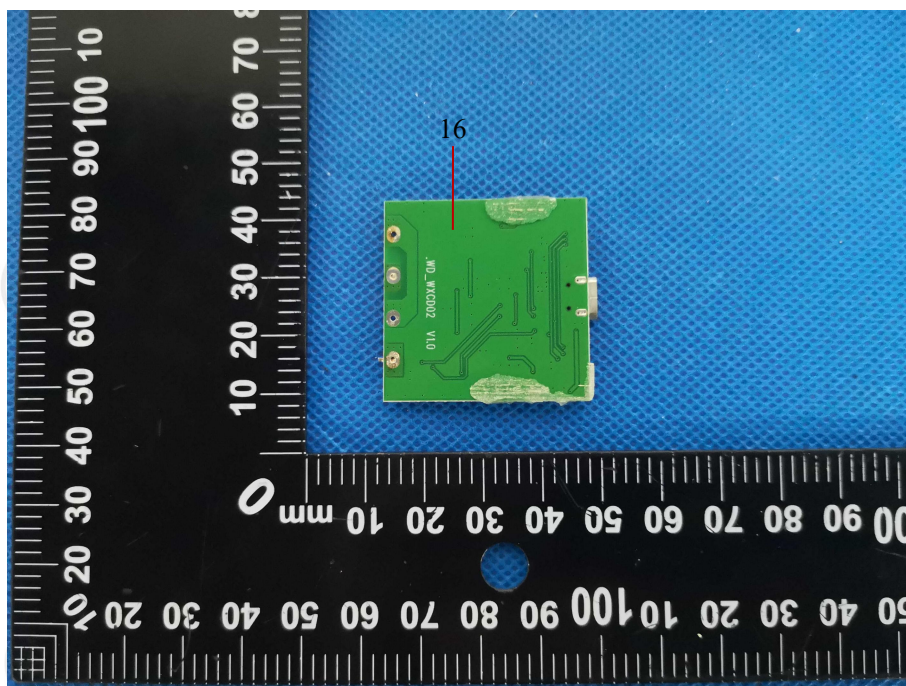
Room 401, A2 Building, The 2nd Industrial Zone of ZhuAo, GuShu Village, XiXiang Town, BaoAn District, ShenZhen
Hotline:400-6633-940 Tel: +86-755-29173399 FAX: +86-755-29179933 <http://www.sit-cert.com>

Sample photo

Appearance photograph of EUT

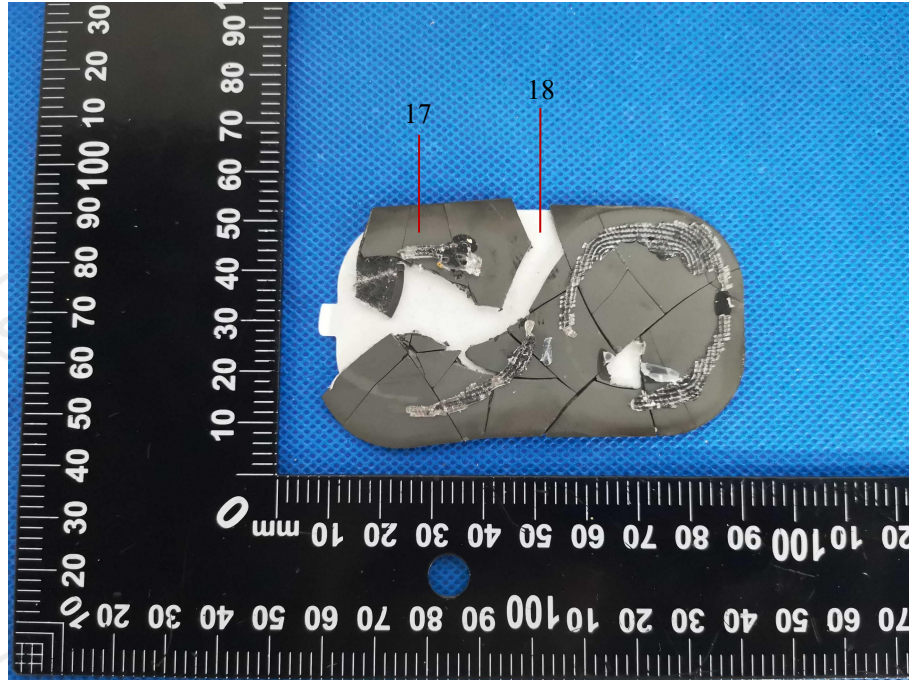


Appearance photograph of EUT

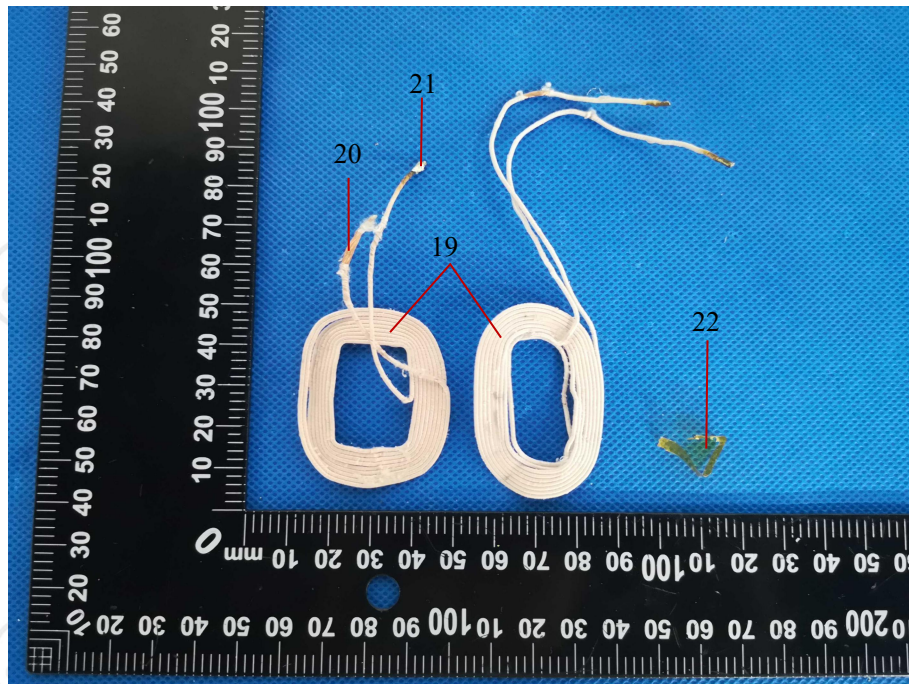


Sample photo

Appearance photograph of EUT



Appearance photograph of EUT



List of apparatus

No.	Name	Model	Calibration Valid Date	USE(✓)
1	ICP-OES	VISTA-MPX	2024/12/28	✓
2	GC-MS	5975i	2024/12/16	✓
3	UV-Vis	Lambda 25	2024/12/16	✓
4	XRF	EDX3000B	2024/12/22	✓

***** END OF REPORT *****